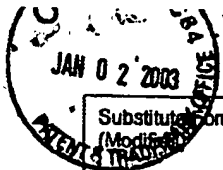


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Application No. <u>09/617736</u>	Prepared by <u>C. Jarnotti</u>	Tracking Number <u>5963268</u>	
Examiner-GAU <u>ULLAH - 2874</u>	Date <u>6/16/04</u>	Week Date <u>6/7/04</u>	
	No. of queries <u>1</u>	<u>(FW)</u>	

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a. Serial No.	f. Foreign Priority	k. Print Claim(s)	p. <u>PTO-1449</u>
b. Applicant(s)	g. Disclaimer	l. Print Fig.	q. PTOL-85b
c. Continuing Data	h. Microfiche Appendix	m. Searched Column	r. Abstract
d. PCT	i. Title	n. PTO-270/328	s. Sheets/Figs
e. Domestic Priority	j. Claims Allowed	o. PTO-892	t. Other

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Information Disclosure Statement by Applicant (Use several sheets if necessary)  (37 CFR §1.98(b))		Applicant Xie et al.	
		Filing Date July 17, 2000	Group Art Unit

**U.S. Patent Documents**

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
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	AL	EP 0 725 289 A	08/07/96	EPO				
	AM	2000-066053	03/03/00	Japan				
	AN	2000-066054	03/03/00	Japan				
	AO							
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